

### FEATURES

- Low on resistance (300  $\Omega$  typical)
- Fast switching times
  - $t_{ON}$  250 ns maximum
  - $t_{OFF}$  250 ns maximum
- Low power dissipation (3.3 mW maximum)
- Fault and overvoltage protection ( $-40$  V to  $+55$  V)
- All switches off with power supply off
- Analog output of on channel clamped within power supplies if an overvoltage occurs
- Latch-up proof construction
- Break-before-make construction
- TTL and CMOS compatible inputs

### APPLICATIONS

- Existing multiplexer applications (both fault-protected and nonfault-protected)
- New designs requiring multiplexer functions

### GENERAL DESCRIPTION

The ADG508F, ADG509F, and ADG528F are CMOS analog multiplexers, with the ADG508F and ADG528F comprising eight single channels and the ADG509F comprising four differential channels. These multiplexers provide fault protection. Using a series n-channel, p-channel, n-channel MOSFET structure, both device and signal source protection is provided in the event of an overvoltage or power loss. The multiplexer can withstand continuous overvoltage inputs from  $-40$  V to  $+55$  V. During fault conditions, the multiplexer input (or output) appears as an open circuit and only a few nanoamperes of leakage current will flow. This protects not only the multiplexer and the circuitry driven by the multiplexer, but also protects the sensors or signal sources that drive the multiplexer.

The ADG508F and ADG528F switch one of eight inputs to a common output as determined by the 3-bit binary address lines A0, A1, and A2. The ADG509F switches one of four differential inputs to a common differential output as determined by the 2-bit binary address lines A0 and A1. The ADG528F has on-chip address and control latches that facilitate microprocessor

### FUNCTIONAL BLOCK DIAGRAMS

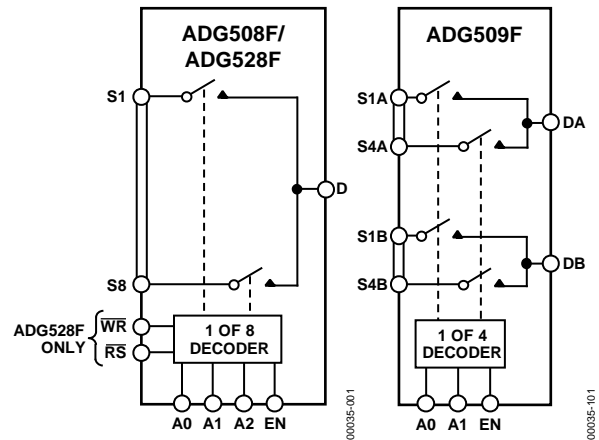


Figure 1.

interfacing. An EN input on each device is used to enable or disable the device. When disabled, all channels are switched off.

### PRODUCT HIGHLIGHTS

1. Fault Protection.  
The ADG508F/ADG509F/ADG528F can withstand continuous voltage inputs from  $-40$  V to  $+55$  V. When a fault occurs due to the power supplies being turned off, all the channels are turned off and only a leakage current of a few nanoamperes flows.
2. On channel turns off while fault exists.
3. Low  $R_{ON}$ .
4. Fast switching times.
5. Break-before-make switching.  
Switches are guaranteed break-before-make so that input signals are protected against momentary shorting.
6. Trench isolation eliminates latch-up.  
A dielectric trench separates the p and n-channel MOSFETs thereby preventing latch-up.

### Rev. E

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**REVISION HISTORY**

**7/09—Rev. D: Rev. E**

Updated Format .....	Universal
Added TSSOP .....	Universal
Updated Outline Dimensions .....	15
Changes to Ordering Guide .....	18

**4/01—Data Sheet Changed from Rev. C to Rev. D.**

Changes to Ordering Guide .....	1
Changes to Specifications Table.....	2
Max Ratings Changed .....	4
Deleted 16-Lead Cerdip from Outline Dimensions .....	11
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# SPECIFICATIONS

## DUAL SUPPLY

$V_{DD} = +15\text{ V} \pm 10\%$ ,  $V_{SS} = -15\text{ V} \pm 10\%$ ,  $GND = 0\text{ V}$ , unless otherwise noted.

Table 1.

Parameter	B Version		Unit	Test Conditions/Comments
	+25°C	-40°C to +85°C		
<b>ANALOG SWITCH</b>				
Analog Signal Range		$V_{SS} + 3$ $V_{DD} - 1.5$	V min V max	
$R_{ON}$	300	350	$\Omega$ typ	$-10\text{ V} \leq V_S \leq +10\text{ V}$ , $I_S = 1\text{ mA}$ ; $V_{DD} = +15\text{ V} \pm 10\%$ , $V_{SS} = -15\text{ V} \pm 10\%$
		400	$\Omega$ max	$-10\text{ V} \leq V_S \leq +10\text{ V}$ , $I_S = 1\text{ mA}$ ; $V_{DD} = +15\text{ V} \pm 5\%$ , $V_{SS} = -15\text{ V} \pm 5\%$
$R_{ON}$ Drift	0.6		%/°C typ	$V_S = 0\text{ V}$ , $I_S = 1\text{ mA}$
$R_{ON}$ Match	5		% max	$V_S = 0\text{ V}$ , $I_S = 1\text{ mA}$
<b>LEAKAGE CURRENTS</b>				
Source OFF Leakage $I_S$ (OFF)	$\pm 0.02$		nA typ	$V_D = \pm 10\text{ V}$ , $V_S = \mp 10\text{ V}$ ;
	$\pm 1$	$\pm 50$	nA max	See Figure 22
Drain OFF Leakage $I_D$ (OFF)	$\pm 0.04$		nA typ	$V_D = \pm 10\text{ V}$ , $V_S = \mp 10\text{ V}$ ;
ADG508F/ADG528F	$\pm 1$	$\pm 60$	nA max	See Figure 23
ADG509F	$\pm 1$	$\pm 30$	nA max	
Channel ON Leakage $I_D$ , $I_S$ (ON)	$\pm 0.04$		nA typ	$V_S = V_D = \pm 10\text{ V}$ ;
ADG508F/ADG528F	$\pm 1$	$\pm 60$	nA max	See Figure 24
ADG509F	$\pm 1$	$\pm 30$	nA max	
<b>FAULT</b>				
Output Leakage Current (With Overvoltage)	$\pm 0.02$		nA typ	$V_S = \pm 33\text{ V}$ , $V_D = 0\text{ V}$ , see Figure 23
	$\pm 2$	$\pm 2$	$\mu\text{A}$ max	
Input Leakage Current (With Overvoltage)	$\pm 0.005$		$\mu\text{A}$ typ	$V_S = \pm 25\text{ V}$ , $V_D = \mp 10\text{ V}$ , see Figure 25
	$\pm 2$		$\mu\text{A}$ max	
Input Leakage Current (With Power Supplies OFF)	$\pm 0.001$		$\mu\text{A}$ typ	$V_S = \pm 25\text{ V}$ , $V_D = V_{EN} = A0, A1, A2 = 0\text{ V}$
	$\pm 2$		$\mu\text{A}$ max	See Figure 26
<b>DIGITAL INPUTS</b>				
Input High Voltage, $V_{INH}$		2.4	V min	
Input Low Voltage, $V_{INL}$		0.8	V max	
Input Current, $I_{INL}$ or $I_{INH}$		$\pm 1$	$\mu\text{A}$ max	$V_{IN} = 0$ or $V_{DD}$
$C_{IN}$ , Digital Input Capacitance	5		pF typ	
<b>DYNAMIC CHARACTERISTICS<sup>1</sup></b>				
$t_{TRANSITION}$	200		ns typ	$R_L = 1\text{ M}\Omega$ , $C_L = 35\text{ pF}$ ;
	300	400	ns max	$V_{S1} = \pm 10\text{ V}$ , $V_{S8} = \mp 10\text{ V}$ ; see Figure 27
$t_{OPEN}$	50		ns typ	$R_L = 1\text{ k}\Omega$ , $C_L = 35\text{ pF}$ ;
	25	10	ns min	$V_S = 5\text{ V}$ ; see Figure 28
$t_{ON}$ ( $\overline{EN}$ , $\overline{WR}$ )	200		ns typ	$R_L = 1\text{ k}\Omega$ , $C_L = 35\text{ pF}$ ;
	250	400	ns max	$V_S = 5\text{ V}$ ; see Figure 29
$t_{OFF}$ ( $\overline{EN}$ , $\overline{RS}$ )	200		ns typ	$R_L = 1\text{ k}\Omega$ , $C_L = 35\text{ pF}$ ;
$t_{SETT}$ , Settling Time	250	400	ns max	$V_S = 5\text{ V}$ ; see Figure 29
0.1%		1	$\mu\text{s}$ typ	$R_L = 1\text{ k}\Omega$ , $C_L = 35\text{ pF}$ ;
0.01%		2.5	$\mu\text{s}$ typ	$V_S = 5\text{ V}$
<b>ADG528F Only</b>				
$t_W$ , Write Pulse Width	100	120	ns min	
$t_S$ , Address, Enable Setup Time		100	ns min	
$t_H$ , Address, Enable Hold Time		10	ns min	
$t_{RS}$ , Reset Pulse Width		100	ns min	

# ADG508F/ADG509F/ADG528F

Parameter	B Version		Unit	Test Conditions/Comments
	+25°C	-40°C to +85°C		
Charge Injection	4		pC typ	$V_S = 0\text{ V}$ , $R_S = 0\ \Omega$ , $C_L = 1\ \text{nF}$ ; see Figure 32 $R_L = 1\ \text{k}\Omega$ , $C_L = 15\ \text{pF}$ , $f = 100\ \text{kHz}$ ; $V_S = 7\ \text{V rms}$ ; see Figure 33
OFF Isolation	68		dB typ	
	50		dB min	
$C_S$ (OFF)	5		pF typ	
$C_D$ (OFF)				
ADG508F/ADG528F	50		pF typ	
ADG509F	25		pF typ	
<b>POWER REQUIREMENTS</b>				
$I_{DD}$	0.1	0.2	mA max	$V_{IN} = 0\text{ V or }5\text{ V}$
$I_{SS}$	0.1	0.1	mA max	

<sup>1</sup> Guaranteed by design, not subject to production test.

## TRUTH TABLES

Table 2. ADG508F Truth Table

A2	A1	A0	EN	ON Switch
X	X	X	0	None
0	0	0	1	1
0	0	1	1	2
0	1	0	1	3
0	1	1	1	4
1	0	0	1	5
1	0	1	1	6
1	1	0	1	7
1	1	1	1	8

X = Don't Care

Table 3. ADG509F Truth Table

A1	A0	EN	ON Switch Pair
X	X	0	None
0	0	1	1
0	1	1	2
1	0	1	3
1	1	1	4

X = Don't Care

Table 4. ADG528F Truth Table

A2	A1	A0	EN	$\overline{WR}$	$\overline{RS}$	ON Switch
X	X	X	X	$\downarrow$	1	Retains previous switch condition
X	X	X	X	X	0	None (address and enable latches cleared)
X	X	X	0	0	1	None
0	0	0	1	0	1	1
0	0	1	1	0	1	2
0	1	0	1	0	1	3
0	1	1	1	0	1	4
1	0	0	1	0	1	5
1	0	1	1	0	1	6
1	1	0	1	0	1	7
1	1	1	1	0	1	8

X = Don't Care

**TIMING DIAGRAMS**

Figure 2 shows the timing sequence for latching the switch address and enable inputs. The latches are level sensitive; therefore, while  $\overline{WR}$  is held low, the latches are transparent and the switches respond to the address and enable inputs. This input data is latched on the rising edge of  $\overline{WR}$ .

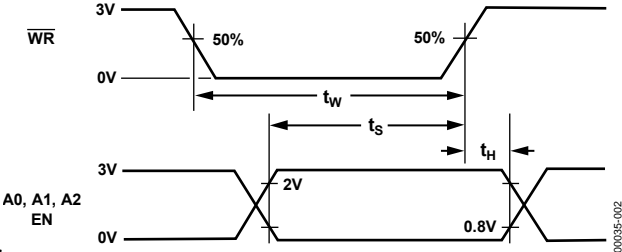


Figure 2. ADG528F Timing Sequence for Latching the Switch Address and Enable Inputs

Figure 3 shows the reset pulsewidth,  $t_{RS}$ , and the reset turnoff time,  $t_{OFF}(\overline{RS})$ . Note that all digital input signals rise and fall times are measured from 10% to 90% of 3 V.  $t_R = t_F = 20$  ns.

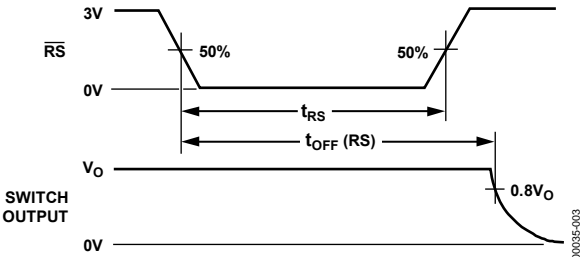


Figure 3. ADG528F Reset Pulse Width

# ADG508F/ADG509F/ADG528F

## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = +25°C unless otherwise noted.

Table 5.

Parameter	Rating
V <sub>DD</sub> to V <sub>SS</sub>	44 V
V <sub>DD</sub> to GND	−0.3 V to +25 V
V <sub>SS</sub> to GND	+0.3 V to −25 V
Digital Input, EN, Ax	−0.3 V to V <sub>DD</sub> + 2 V or 20 mA, whichever occurs first
V <sub>S</sub> , Analog Input Overvoltage with Power On	V <sub>SS</sub> − 25 V to V <sub>DD</sub> + 40 V
V <sub>S</sub> , Analog Input Overvoltage with Power Off	−40 V to +55 V
Continuous Current, S or D	20 mA
Peak Current, S or D (Pulsed at 1 ms, 10% Duty Cycle Max)	40 mA
Operating Temperature Range Industrial (B Version)	−40°C to +85°C
Storage Temperature Range	−65°C to +150°C
Junction Temperature	150°C
TSSOP	
θ <sub>JA</sub> , Thermal Impedance Plastic Package	112°C/W
θ <sub>JA</sub> , Thermal Impedance	
16-Lead	117°C/W
18-Lead	110°C/W
Lead Temperature, Soldering (10 sec)	260°C
SOIC Package	
θ <sub>JA</sub> , Thermal Impedance	
Narrow Body	77°C/W
Wide Body	75°C/W
Lead Temperature, Soldering	
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C
PLCC Package	
θ <sub>JA</sub> , Thermal Impedance	90°C/W
Lead Temperature, Soldering	
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 4. ADG508F Pin Configuration TSSOP/DIP/SOIC



Figure 6. ADG528F Pin Configuration DIP



Figure 5. ADG509F Pin Configuration TSSOP/DIP/SOIC

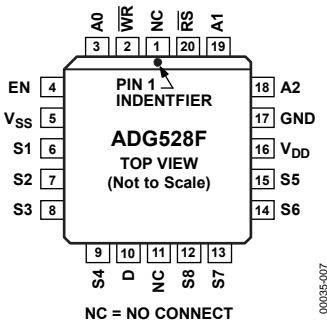


Figure 7. ADG528F Pin Configuration PLCC

## TYPICAL PERFORMANCE CHARACTERISTICS

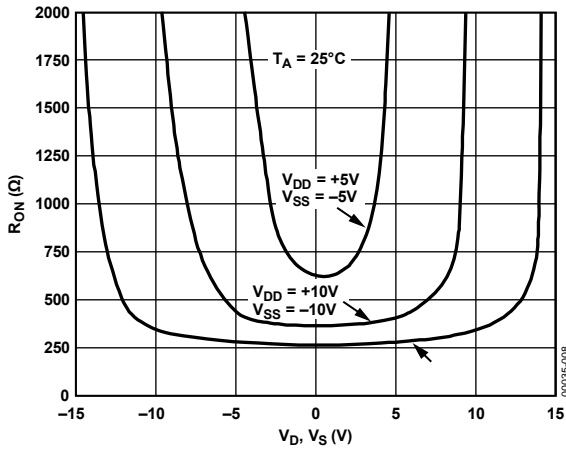


Figure 8. On Resistance as a Function of  $V_D$  ( $V_S$ )



Figure 11. On Resistance as a Function of  $V_D$  ( $V_S$ ) for Different Temperatures

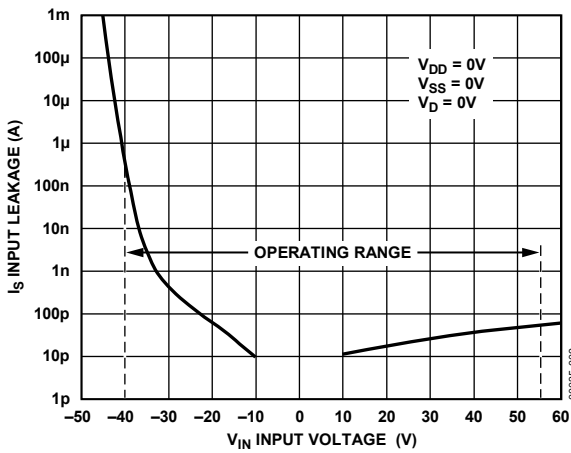


Figure 9. Input Leakage Current as a Function of  $V_S$  (Power Supplies Off) During Overvoltage Conditions

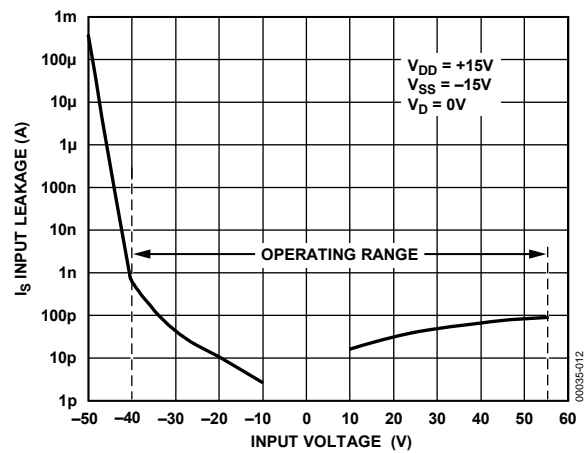


Figure 12. Input Leakage Current as a Function of  $V_S$  (Power Supplies On) During Overvoltage Conditions

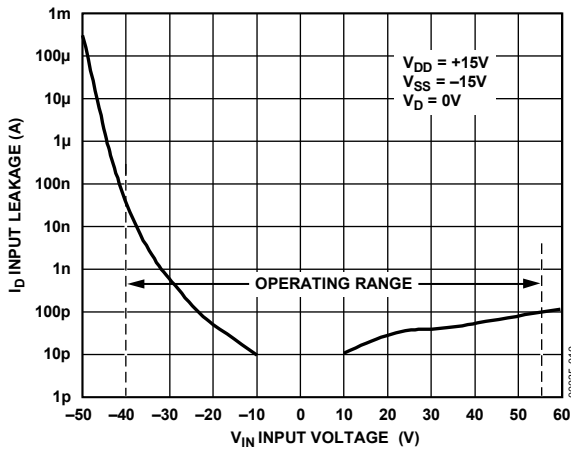


Figure 10. Output Leakage Current as a Function of  $V_S$  (Power Supplies On) During Overvoltage Conditions



Figure 13. Leakage Currents as a Function of  $V_D$  ( $V_S$ )



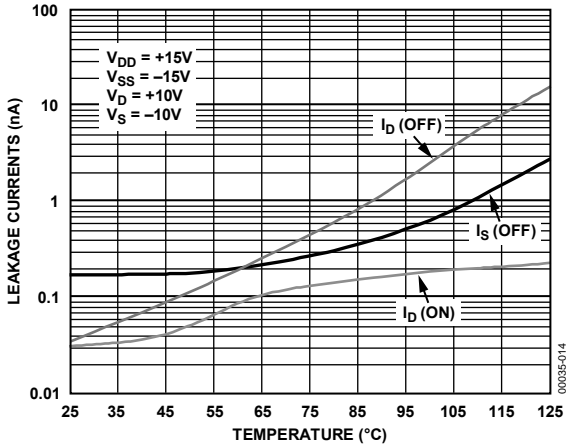


Figure 14. Leakage Currents as a Function of Temperature

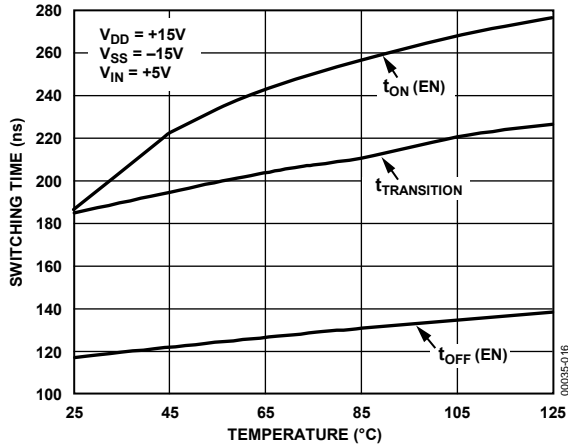


Figure 16. Switching Time vs. Temperature

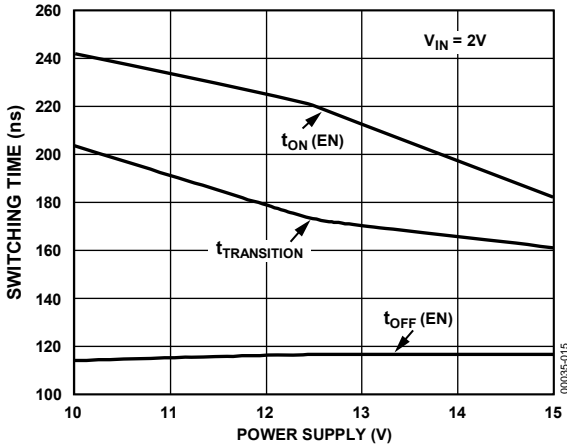


Figure 15. Switching Time vs. Power Supply

## TERMINOLOGY

<b>V<sub>DD</sub></b> Most Positive Power Supply Potential.	<b>t<sub>ON</sub> (EN)</b> Delay time between the 50% and 90% points of the digital input and switch on condition.
<b>V<sub>SS</sub></b> Most Negative Power Supply Potential.	<b>t<sub>OFF</sub> (EN)</b> Delay time between the 50% and 90% points of the digital input and switch off condition.
<b>GND</b> Ground (0 V) Reference.	<b>t<sub>TRANSITION</sub></b> Delay time between the 50% and 90% points of the digital inputs and the switch on condition when switching from one address state to another.
<b>R<sub>ON</sub></b> Ohmic Resistance between D and S.	<b>t<sub>OPEN</sub></b> “OFF” time measured between 80% points of both switches when switching from one address state to another.
<b>R<sub>ON</sub> Drift</b> Change in R <sub>ON</sub> when temperature changes by one degree Celsius.	<b>V<sub>INL</sub></b> Maximum input voltage for Logic 0.
<b>R<sub>ON</sub> Match</b> Difference between the R <sub>ON</sub> of any two channels.	<b>V<sub>INH</sub></b> Minimum input voltage for Logic 1.
<b>I<sub>S</sub> (OFF)</b> Source leakage current when the switch is off.	<b>I<sub>INL</sub> (I<sub>INH</sub>)</b> Input current of the digital input.
<b>I<sub>D</sub> (OFF)</b> Drain leakage current when the switch is off.	<b>Off Isolation</b> A measure of unwanted signal coupling through an off channel.
<b>I<sub>D</sub>, I<sub>S</sub> (ON)</b> Channel leakage current when the switch is on.	<b>Charge Injection</b> A measure of the glitch impulse transferred from the digital input to the analog output during switching.
<b>V<sub>D</sub> (V<sub>S</sub>)</b> Analog Voltage on Terminals D, S.	<b>I<sub>DD</sub></b> Positive Supply Current.
<b>C<sub>S</sub> (OFF)</b> Channel input capacitance for off condition.	<b>I<sub>SS</sub></b> Negative Supply Current.
<b>C<sub>D</sub> (OFF)</b> Channel output capacitance for off condition.	
<b>C<sub>D</sub>, C<sub>S</sub> (ON)</b> On Switch Capacitance.	
<b>C<sub>IN</sub></b> Digital Input Capacitance.	

## THEORY OF OPERATION

The ADG508F/ADG509F/ADG528F multiplexers are capable of withstanding overvoltages from  $-40\text{ V}$  to  $+55\text{ V}$ , irrespective of whether the power supplies are present or not. Each channel of the multiplexer consists of an n-channel MOSFET, a p-channel MOSFET, and an n-channel MOSFET, connected in series. When the analog input exceeds the power supplies, one of the MOSFETs will switch off, limiting the current to submicroamp levels, thereby preventing the overvoltage from damaging any circuitry following the multiplexer. Figure 17 illustrates the channel architecture that enables these multiplexers to withstand continuous overvoltages.

When an analog input of  $V_{SS} + 3\text{ V}$  to  $V_{DD} - 1.5\text{ V}$  is applied to the ADG508F/ADG509F/ADG528F, the multiplexer behaves as a standard multiplexer, with specifications similar to a standard multiplexer, for example, the on-resistance is  $400\ \Omega$  maximum. However, when an overvoltage is applied to the device, one of the three MOSFETs will turn off.

Figure 17 to Figure 20 show the conditions of the three MOSFETs for the various overvoltage situations. When the analog input applied to an ON channel approaches the positive power supply line, the n-channel MOSFET turns OFF since the voltage on the analog input exceeds the difference between  $V_{DD}$  and the n-channel threshold voltage ( $V_{TN}$ ). When a voltage more negative than  $V_{SS}$  is applied to the multiplexer, the p-channel MOSFET will turn off since the analog input is more negative than the difference between  $V_{SS}$  and the p-channel threshold voltage ( $V_{TP}$ ). Since  $V_{TN}$  is nominally  $1.5\text{ V}$  and  $V_{TP}$  is typically  $3\text{ V}$ , the analog input range to the multiplexer is limited to  $-12\text{ V}$  to  $+13.5\text{ V}$  when a  $\pm 15\text{ V}$  power supply is used.

When the power supplies are present but the channel is off, again either the p-channel MOSFET or one of the n-channel MOSFETs will turn off when an overvoltage occurs.

Finally, when the power supplies are off, the gate of each MOSFET will be at ground. A negative overvoltage switches on the first n-channel MOSFET but the bias produced by the overvoltage causes the p-channel MOSFET to remain turned off. With a positive overvoltage, the first MOSFET in the series will remain off since the gate to source voltage applied to this MOSFET is negative.

During fault conditions, the leakage current into and out of the ADG508F/ADG509F/ADG528F is limited to a few microamps. This protects the multiplexer and succeeding circuitry from over stresses as well as protecting the signal sources which drive the multiplexer. Also, the other channels of the multiplexer will be undisturbed by the overvoltage and will continue to operate normally.

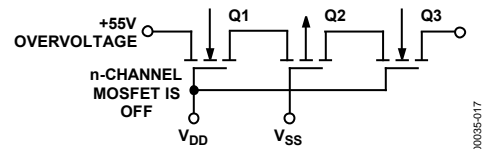


Figure 17. +55 V Overvoltage Input to the On Channel

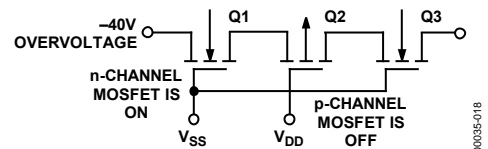


Figure 18.  $-40\text{ V}$  Overvoltage on an Off Channel with Multiplexer Power On

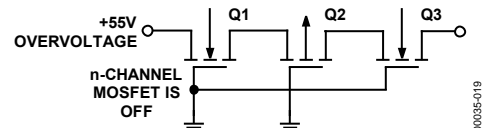


Figure 19. +55 V Overvoltage with Power Off

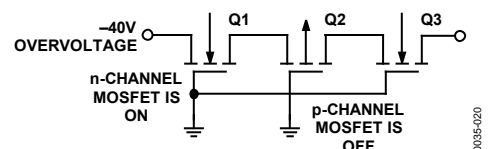


Figure 20.  $-40\text{ V}$  Overvoltage with Power Off

## TEST CIRCUITS



Figure 21. On Resistance

00035-021

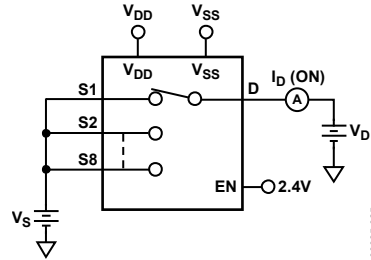


Figure 24.  $I_D$  (On)

00035-025

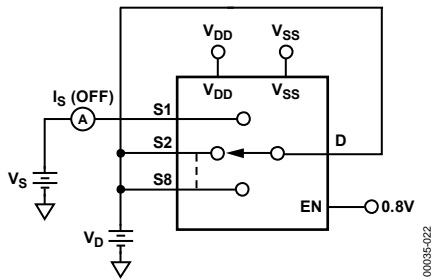


Figure 22.  $I_S$  (Off)

00035-022

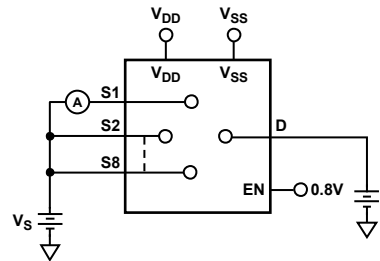


Figure 25. Input Leakage Current (with Overvoltage)

00035-028

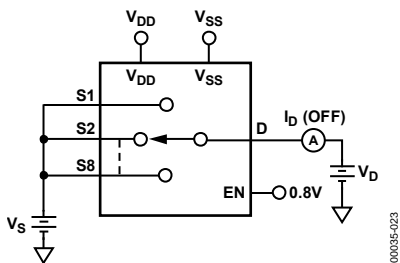


Figure 23.  $I_D$  (Off)

00035-023

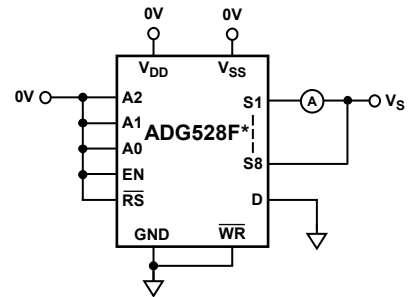


Figure 26. Input Leakage Current (with Power Supplies Off)

00035-027

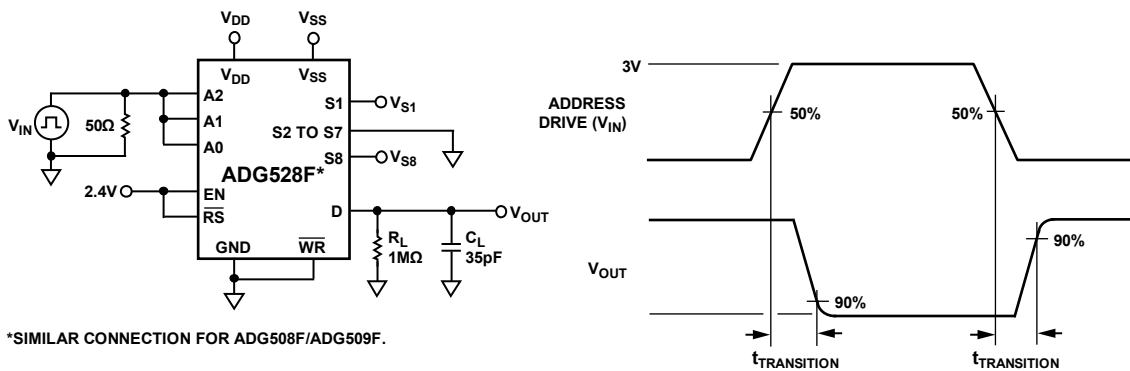


Figure 27. Switching Time of Multiplexer,  $t_{\text{TRANSITION}}$

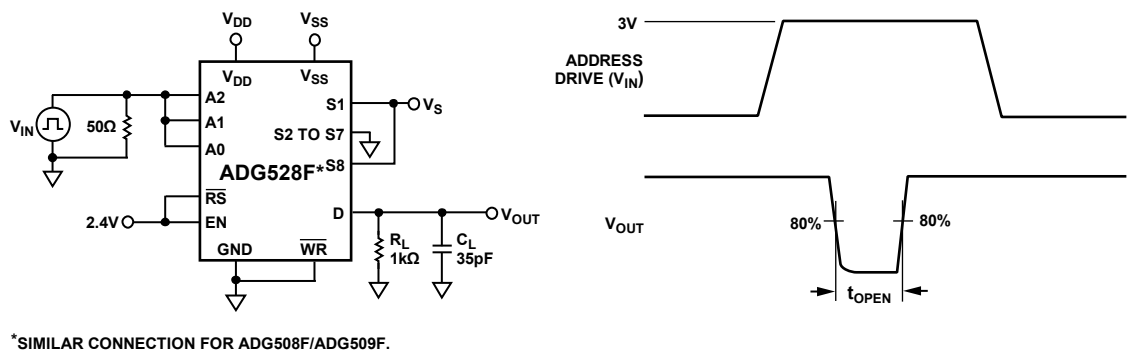


Figure 28. Break-Before-Make Delay,  $t_{\text{OPEN}}$

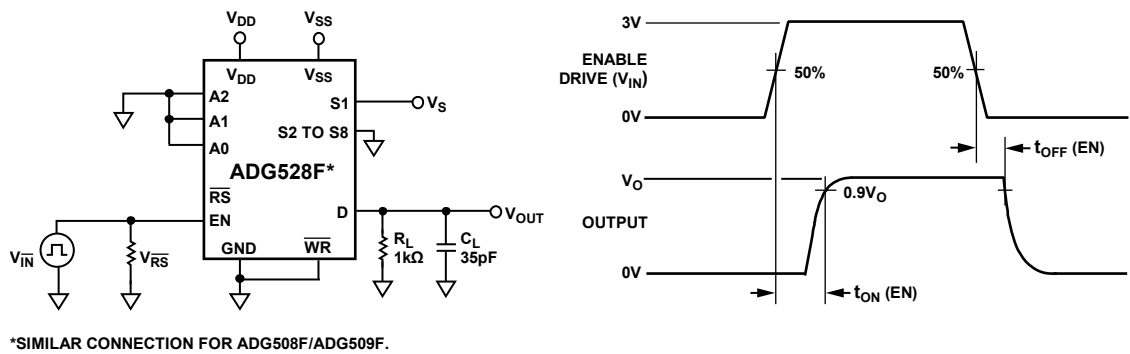


Figure 29. Enable Delay,  $t_{\text{ON}}(\text{EN})$ ,  $t_{\text{OFF}}(\text{EN})$



Figure 30. Write Turn-On Time,  $t_{\text{ON}}(\overline{\text{WR}})$

# ADG508F/ADG509F/ADG528F



\*SIMILAR CONNECTION FOR ADG508F/ADG509F.



Figure 31. Reset Turn-Off Time,  $t_{OFF}(\overline{RS})$

00035-032



\*SIMILAR CONNECTION FOR ADG508F/ADG509F.

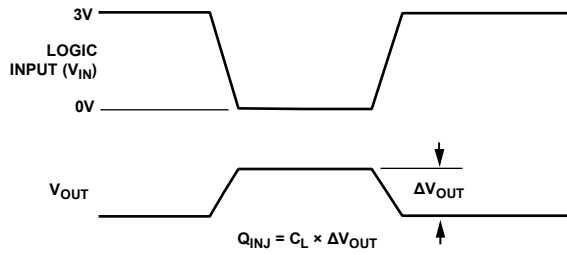
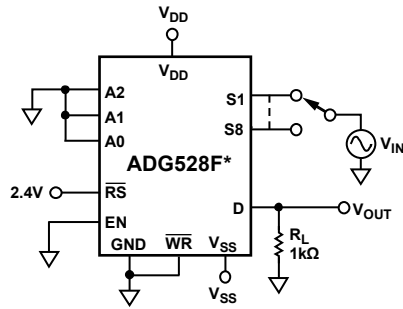


Figure 32. Charge Injection

00035-033



\*SIMILAR CONNECTION FOR ADG508F/ADG509F.

Figure 33. Off Isolation

00035-034

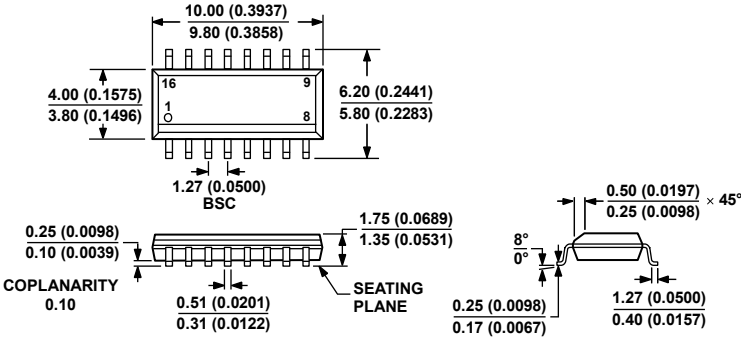
OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-001-AB  
 CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN. CORNER LEADS MAY BE CONFIGURED AS WHOLE OR HALF LEADS.

Figure 34. 16-Lead Plastic Dual In-Line Package [PDIP] Narrow Body (N-16)

Dimensions shown in inches and (millimeters)

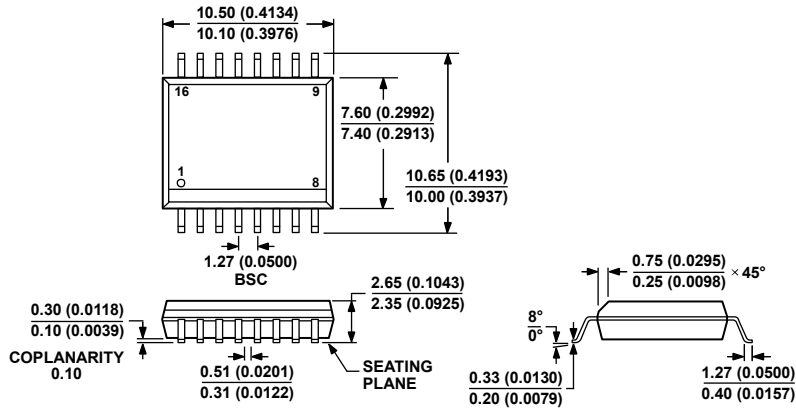


COMPLIANT TO JEDEC STANDARDS MS-012-AC  
 CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 35. 16-Lead Standard Small Outline Package [SOIC-N] Narrow Body (R-16)

Dimensions shown in millimeters and (inches)

# ADG508F/ADG509F/ADG528F

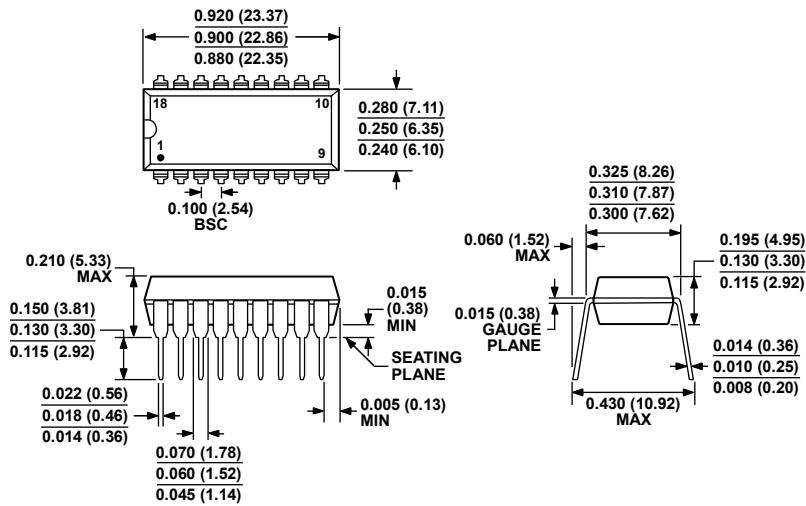


COMPLIANT TO JEDEC STANDARDS MS-013-AA  
 CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 36. 16-Lead Standard Small Outline Package [SOIC-W] Wide Body (RW-16)

Dimensions shown in millimeters and (inches)

032707-B



COMPLIANT TO JEDEC STANDARDS MS-001  
 CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.  
 CORNER LEADS MAY BE CONFIGURED AS WHOLE OR HALF LEADS.

Figure 37. 18-Lead Plastic Dual In-Line Package [PDIP] Narrow Body (N-18)

Dimensions shown in inches and (millimeters)

070706-A





COMPLIANT TO JEDEC STANDARDS MO-047-AA  
 CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 38. 20-Lead Plastic Leaded Chip Carrier [PLCC]  
 (P-20)

Dimensions shown in inches and (millimeters)



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 39. 16-Lead Thin Shrink Small Outline Package [TSSOP]  
 (RU-16)

Dimensions shown in millimeters

# ADG508F/ADG509F/ADG528F

## ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
ADG508FBN	-40°C to +85°C	16-Lead PDIP	N-16
ADG508FBNZ	-40°C to +85°C	16-Lead PDIP	N-16
ADG508FBRN	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG508FBRN-REEL7	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG508FBRNZ	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG508FBRNZ-REEL7	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG508FBRW	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG508FBRWZ	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG508FBRWZ-REEL	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG508FBRUZ	-40°C to +85°C	16-Lead TSSOP	RU-16
ADG508FBRUZ-REEL7	-40°C to +85°C	16-Lead TSSOP	RU-16
ADG509FBN	-40°C to +85°C	16-Lead PDIP	N-16
ADG509FBNZ	-40°C to +85°C	16-Lead PDIP	N-16
ADG509FBRN	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG509FBRN-REEL7	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG509FBRNZ	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG509FBRNZ-REEL7	-40°C to +85°C	16-Lead SOIC_N	R-16
ADG509FBRW	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG509FBRW-REEL	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG509FBRWZ	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG509FBRWZ-REEL	-40°C to +85°C	16-Lead SOIC_W	RW-16
ADG509FBRUZ	-40°C to +85°C	16-Lead TSSOP	RU-16
ADG509FBRUZ-REEL7	-40°C to +85°C	16-Lead TSSOP	RU-16
ADG528FBN	-40°C to +85°C	18-Lead PDIP	N-18
ADG528FBNZ	-40°C to +85°C	18-Lead PDIP	N-18
ADG528FBP	-40°C to +85°C	20-Lead PLCC	P-20
ADG528FBP-REEL	-40°C to +85°C	20-Lead PLCC	P-20
ADG528FBPZ	-40°C to +85°C	20-Lead PLCC	P-20

**NOTES**

**NOTES**



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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